

Three-wire Serial EEPROM

Description

The ACE93C46A/56A/66A series are 1024/2048/4096 bits of serial Electrical Erasable and Programmable Read Only Memory, commonly known as EEPROM. They are organized as 64/128/256 words of 16 bits each when the ORG pin is connected to VCC (or unconnected) and 128/256/512 words of 8 bits (1 byte) each when the ORG pin is tied to ground. The devices are fabricated with proprietary advanced CMOS process for low power and low voltage applications. These devices are available in standard 8-lead DIP, 8-lead JEDEC SOP, 8-lead TSSOP and 8-lead USON3*2 packages. Our extended V_{CC} range (1.8V to 5.5V) devices enables wide spectrum of applications.

The ACE93C46A/56A/66A is enabled through the Chip Select pin (CS), and accessed via a 3-wire serial interface consisting of Data Input (DI), Data Output (DO), and Shift Clock (SCL). Upon receiving a READ instruction at DI, the address is decoded and the data is clocked out serially on the data output pin DO. The WRITE cycle is completely self-timed and no separate ERASE cycle is required before WRITE. The WRITE cycle is only enabled when the part is in the ERASE/WRITE ENABLE state. Once a device begins its self-timed program procedure, the data out pin (DO) can indicate the READY/BUSY status by rising chip select (CS).

Features

- Standard Voltage and Low Voltage Operation:
 - ACE 93C46A/56A/66A: $V_{CC} = 1.8V$ to 5.5V
- User Selectable Internal Organization:

ACE 93C46A:128 x 8 or 64 x 16

ACE 93C56A:256 x 8 or 128 x 16

ACE 93C66A:512 x 8 or 256 x 16

- 2 MHz Clock Rate (5V) Compatibility.
- Industry Standard 3-wire Serial Interface.
- Self-Timed ERASE/WRITE Cycles (5ms max including auto-erase).
- Automatic ERAL before WRAL.
- Sequential READ Function.
- High Reliability: Typical 1 Million Erase/Write Cycle Endurance.
- 100 Years Data Retention.
- Industrial Temperature Range (-40°C to 85°C).
- Standard 8-pin DIP/SOP/TSSOP/UDFN/USON3*2 Pb-free Packages



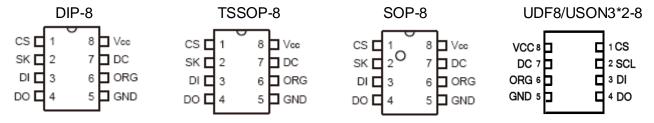
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Absolute Maximum Ratings

Industrial operating temperature	-40°C to 85°C
Storage temperature	-50°ℂ to 125°ℂ
Input voltage on any pin relative to ground	-0.3V to V_{CC} + 0.3V
Maximum voltage	8V

^{*}Notice: Stresses exceed those listed under "Absolute Maximum Rating" may cause permanent damage to the device. Functional operation of the device at conditions beyond those listed in the specification is not guaranteed. Prolonged exposure to extreme conditions may affect device reliability or functionality.

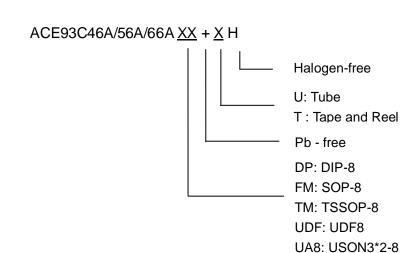
Packaging Type



Pin Configurations

cogu.	44.4.4	
NO	Pin Name	Function
1	CS	Chip select
2	SK	Serial Data Clock
3	DI	Serial Data Input
4	DO	Serial Data Output
5	GND	Ground
6	ORG	Internal Organization
7	DC	Don't Connect
8	Vcc	Power Supply

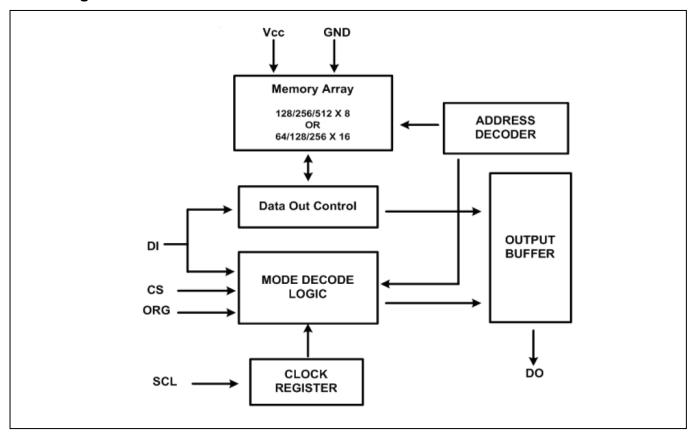
Ordering information





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Block Diagram



Pin Descriptions

(A) SERIAL CLOCK (SCL)

The rising edge of this SCL input is to latch data into the EEPROM device while the rising edge of this clock is to clock data out of the EEPROM device.

- (B) CHIP SELECT (CS)
 - This is the chip select input signal for the serial EEPROM device.
- (C) SERIAL DATA INPUT (DI)
 - This is data input signal for the serial device.
- (D) SERIAL DATA OUTPUT (DO)
 - This is data output signal for the serial device.
- (E) INTERNAL ORGANIZATION (ORG)

This is internal organization input signal for the serial EEPROM device. When the ORG pin is connected to VCC or unconnected the EEPROM is organized as 64/128/256 word of 16 bits each and when ORG pin is connected to ground the EEPROM is organized as 128/256/512 byte of 8 bits each. Typically, these signals are hardwired to either VIH or VIL. If left unconnected, they are internally recognized as VIH.



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Memory Organization

The ACE93C46A/56A/66A memory is organized either as bytes (x8) or as words (x16). If Internal Organization (ORG) is unconnected (or connected to VCC) the words (x16) organization is selected; When Internal Organization is connected to ground the bytes (x8) organization is selected.

Instruction set

Inctruction	Device	SB	Ор	Addr	ess	Da	ata	Comments	
Instruction	Type	90	code	*8 (1) (2)	*16 ^{(1) (3)}	*8	*16	Comments	
								Reads date	
	ACE93C46A	1	10	A_6-A_0	A ₅ -A ₀			stored in	
READ	ACE93C56A	1	10	A ₈ -A ₀	A ₇ -A ₀			memory, at	
	ACE93C66A	1	10	A_8 - A_0	A ₇ -A ₀			specified	
								address.	
								Write enable	
	ACE93C46A	1	00	11XXXXX	11XXXX			must precede	
EWEN	ACE93C56A	1	00	11XXXXXXXX	11XXXXXX			all programming	
	ACE93C66A	1	00	11XXXXXXXX	11XXXXXX				
								modes.	
	ACE93C46A	1	00	00XXXXX	00XXXX			Disables all	
EWDS	ACE93C56A	1	00	00XXXXXXX	00XXXXXX			programming	
	ACE93C66A	1	00	00XXXXXXX	00XXXXXX			instructions.	
	ACE93C46A	1	11	A ₆ -A ₀	A ₅ -A ₀			Erase memory	
ERASE	ACE93C56A	1	11	A_8 - A_0	A ₇ -A ₀			location A _n - A ₀ .	
	ACE93C66A	1	11	A ₈ -A ₀	A ₇ -A ₀			0	
	ACE93C46A	1	01	A_6-A_0	A ₅ -A ₀	D_7 - D_0	D ₁₅ -D ₀	Writes memory	
WRITE	ACE93C56A	1	01	A_8 - A_0	A_7 - A_0	D_7 - D_0	D ₁₅ -D ₀	location A _n -A ₀ .	
	ACE93C66A	1	01	A ₈ -A ₀	A ₇ -A ₀	D_7 - D_0	D ₁₅ -D ₀		
	ACE93C46A	1	00	10XXXXX	10XXXX			Erases all	
ERAL	ACE93C56A	1	00	10XXXXXXX	10XXXXXX			memory	
	ACE93C66A	1	00	10XXXXXXX	10XXXXXX			locations.	
	ACE93C46A	1	00	01XXXXX	01XXXX	D ₇ -D ₀	D ₁₅ -D ₀	Writes all	
WRAL	ACE93C56A	1	00	01XXXXXXX	01XXXXXX	D_7 - D_0	D ₁₅ -D ₀	memory	
	ACE93C66A	1	00	01XXXXXXX	01XXXXXX	D_7 - D_0	D ₁₅ -D ₀	locations.	

(A) START BIT(SB)

Each instruction is preceded by a rising edge on Chip Select (CS) with Serial Clock (SCL) being held Low.

(B) OPERATION CODE (OP-CODE)

Two op-code bits, read on Serial Data Input (DI) during the rising edge of Serial Clock (SCL).



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(C) ADDRESS

The address bits of the byte or word that is to be accessed. For the ACE93C46A, the address is made up of 6 bits for the x16 organization or 7 bits for x8 organization. For the ACE93C56A, the address is made up of 7 bits for the x16 organization or 8 bits for x8 organization. For the ACE 93C66A, the address is made up of 8 bits for the x16 organization or 9 bits for x8 organization.

(D) DATA

The data bits of the byte or word that is to be accessed. For the ACE93C46A/56A/66A, the data is made up of 16 bits (word) for the x16 organization or 8 bits (byte) for x8 organization.

Instruction Sets Description

(A) READ

The Read (READ) instruction contains the Address code for the memory location to be read. After the instruction and address are decoded, data from the selected memory location is available at the serial output pin DO. Output data changes are synchronized with the rising edges of serial clock SK. It should be noted that when a dummy bit (logic "0") precedes the 8- or 16-bit data output string.

(B) ERASE/WRITE ENABLE

To assure data integrity, the part automatically goes into the Erase/Write Disable (EWDS) state when power is first applied. An Erase/Write Enable (EWEN) instruction must be executed first before any programming instructions can be carried out. Please note that once in the Erase/Write Enable state, programming remains enabled until an Erase/Write Disable (EWDS) instruction is executed or VCC power is removed from the part.

(C) ERASE/WRITE DISABLE

To protect against accidental data, disturb, the Erase/Write Disable (EWDS) instruction disables all programming modes and should be executed after all programming operations. The operation of the READ instruction is independent of both the EWEN and EWDS instructions and can be executed at any time.

(D) ERASE

The Erase (ERASE) instruction programs all bits in the specified memory location to the logical "1" state. The self-timed erase cycle starts once the ERASE instruction and address are decoded. The DO pin outputs the READY/BUSY status of the part if CS is brought high after being kept low for a minimum of 250 ns (tcs). A logic "1" at pin DO indicates that the selected memory location has been erased, and the part is ready for another instruction.



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(E) WRITE

The Write (WRITE) instruction contains the 8 or 16 bits of data to be written into the specified memory location. The self-timed programming cycle, twp, starts after the last bit of data is received at serial data input pin DI. The DO pin outputs the READY/BUSY status of the part if CS is brought high after being kept low for a minimum of 250 ns (ttp). A logic "0" at DO indicates that programming is still in progress. A logic "1" indicates that the memory location at the specified address has been written with the data pattern contained in the instruction and the part is ready for further instructions. A READY/BUSY status cannot be obtained if the CS is brought high after the end of the self-timed programming cycle, twp.

(F) ERASE ALL

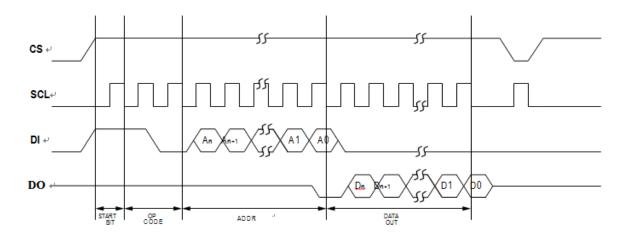
The Erase All (ERAL) instruction programs every bit in the memory array to the logic "1" state and is primarily used for testing purposes. The DO pin outputs the READY/BUSY status of the part if CS is brought high after being kept low for a minimum of 250 ns (t_{CS}). The ERAL instruction is valid only at VCC = 5.0V \pm 10%.

(G) WRITE ALL

The Write All (WRAL) instruction programs all memory locations with the data patterns specified in the instruction. The DO pin outputs the READY/BUSY status of the part if CS is brought high after being kept low for a minimum of 250 ns (t_{CS}). The WRAL instruction is valid only at $V_{CC} = 5.0V \pm 10\%$.

Timing Diagrams

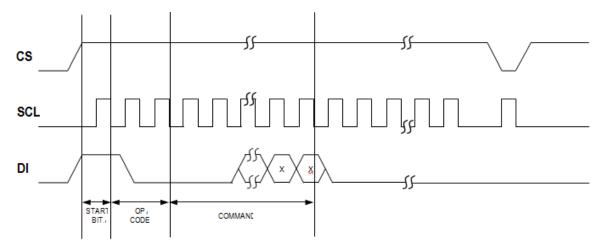
READ Timing



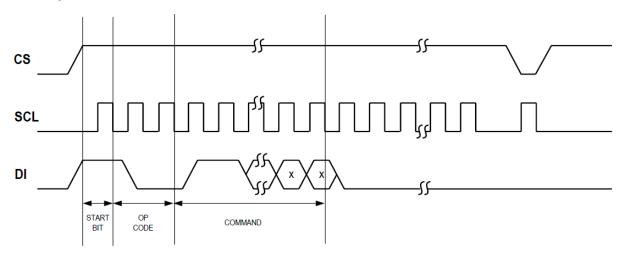


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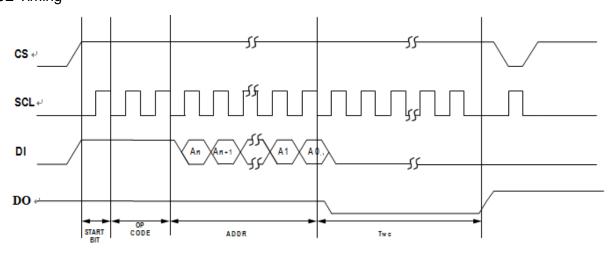
EWDS Timing



EWEN Timing



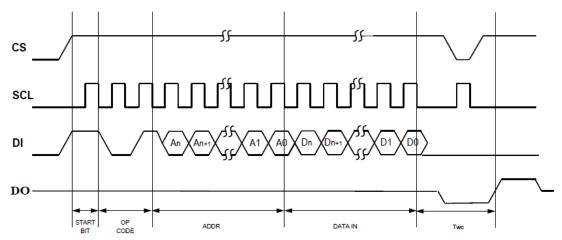
ERASE Timing



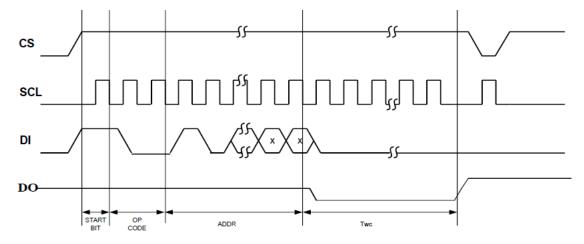


Three-wire Serial EEPROM

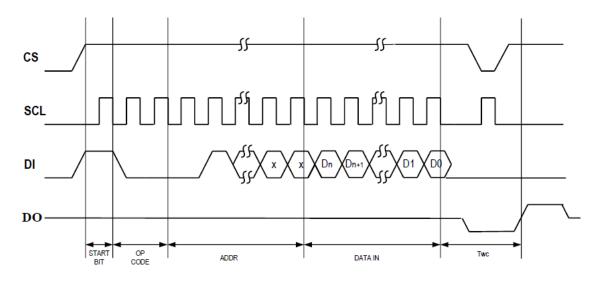
WRITE Timing



ERAL Timing (1)



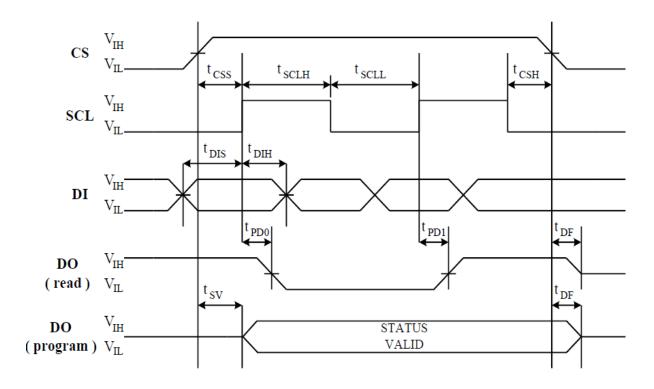
WRAL Timing (2)



Note : 1. Valid only at V $_{\rm CC}$ =4.5V to 5.5V $\,$ 2. Valid only at V $_{\rm CC}$ =4.5V to 5.5V



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AC characteristics

ACE93C46A/56A/66A

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Applicable over recommended operating range from: T_{AI} = -40°C to 85°C, V_{CC} =+1.8V to 5.5V, T_{AC} = 0°C to +70°C, V_{CC} = +1.8V to +5.5V (unless otherwise noted).

Symbol	Parameter	Test Co	ondition	Min	Тур	Max	Units	
		4.5V≤V _{CC} ≤5.5V		0		2		
f_{SCL}	SCL Clock Frequency	2.7V≤V _{CC} ≤5.5V		0		1	MH_Z	
		1.8V≤V _{CC} ≤5.5V	0			0.25		
		4.5V≤V _{CC} ≤5.5V		250				
t _{SHLH}	SCL High Time	2.7V≤V _{CC} ≤5.5V		250			ns	
	-	1.8V≤V _{CC} ≤5.5V		1000				
		4.5V≤V _{CC} ≤5.5V		250				
t _{SCLL}	SCL Low Time	2.7V≤V _{CC} ≤5.5V		250			ns	
		1.8V≤V _{CC} ≤5.5V		1000				
	Minimum CO Lass	4.5V≤V _{CC} ≤5.5V		250				
t_{CS}	Minimum CS Low	2.7V≤V _{CC} ≤5.5V		250			ns	
	Time	1.8V≤V _{CC} ≤5.5V		1000				
			4.5V≤V _{CC} ≤5.5V	50				
t _{CSS}	CS Setup Time	Relative to SCL	2.7V≤V _{CC} ≤5.5V	50			ns	
			1.8V≤V _{CC} ≤5.5V	200				
			4.5V≤V _{CC} ≤5.5V	100				
t _{DIS}	DI Setup Time	Relative to SCL	2.7V≤V _{CC} ≤5.5V	100			ns	
2.0			1.8V≤V _{CC} ≤5.5V	400				
t _{CSH}	CS Hold Time	Relative to SCL		0			ns	
			4.5V≤V _{CC} ≤5.5V	100				
t _{DIH}	DI Setup Time	Relative to SCL	2.7V≤V _{CC} ≤5.5V	100			ns	
	•		1.8V≤V _{CC} ≤5.5V	400				
			4.5V≤V _{CC} ≤5.5V			250		
t _{PD1}	Output Delay to"1"	AC Test	2.7V≤V _{CC} ≤5.5V			250	ns	
	. ,		1.8V≤V _{CC} ≤5.5V			1000		
			4.5V≤V _{CC} ≤5.5V			250		
t_{PD0}	Output Delay to"0"	AC Test	2.7V≤V _{CC} ≤5.5V			250	ns	
	. ,		1.8V≤V _{CC} ≤5.5V			1000		
			4.5V≤V _{CC} ≤5.5V			250		
tsv	CS to Status Valid	AC Test	2.7V≤V _{CC} ≤5.5V			250	ns	
			1.8V≤V _{CC} ≤5.5V			1000		
	00 to DO 1 11111		4.5V≤V _{CC} ≤5.5V			100		
t_DF	CS to DO in High	AC Test CS=V _{IL}	2.7V≤V _{CC} ≤5.5V			100	ns	
	Impedance		1.8V≤V _{CC} ≤5.5V			400		
t _{WC}	Write Cycle Time		4.5V≤V _{CC} ≤5.5V		3	10	ms	



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DC characteristics

Applicable over recommended operating range from T_A = -40°C to 85°C, V_{CC} = As Specified, CL = 1 TTL Gate and 100 pF (unless otherwise noted).

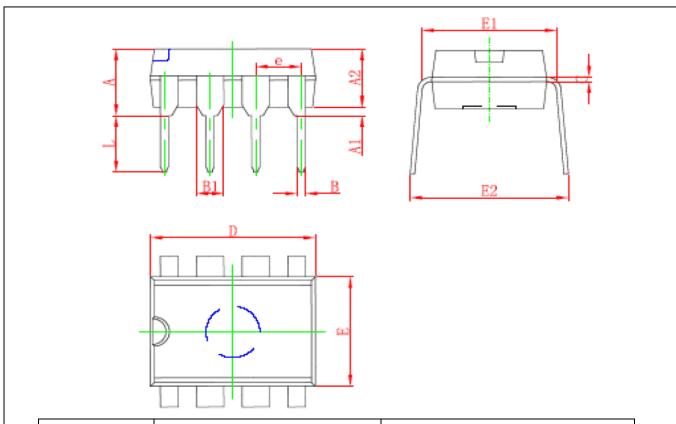
Symbol	Parameter	Tes	t condition	Min	Тур	Max	Units
V_{CC1}	Supply voltage			1.8		5.5	V
V_{CC2}	Supply voltage					5.5	
V _{CC3}	Supply voltage			2.7		5.5	
V _{CC4}	Supply voltage			4.5		5.5	
ı	Supply	V _{CC} =5.0V,	READ at 1.0 MHz		0.5	2.0	mA
I _{CC}	Supply	v _{CC} =3.0 v,	WRITE at 1.0 MHz		0.5	2.0	mA
I _{SB1}	Standby current	V _{CC} =1.8V	CS=0V			0.1	μΑ
I _{SB2}	Standby current	V _{CC} =2.5V	CS=0V			1.5	μΑ
I _{SB3}	Standby current	V _{CC} =2.7V	CS=0V			1.5	μA
I _{SB4}	Standby current	V _{CC} =5.0V	CS=0V			1.5	μA
ILI	Input leakage	V_{in}	$V_{in} = 0V \text{ to } V_{CC}$		0.1	1.0	μΑ
I_{OL}	Output low voltage	V_{in}	= 0V to V _{CC}		0.1	1.0	μΑ
V_{IL1}	Input low voltage	4.5\/	′ ≤V _{CC} ≤ 5.5V	-0.6		8.0	V
V_{IH1}	Input high voltage	4.5 V	≥ V CC ≥ 3.5 V	2.0		V _{CC} +1	V
V_{IL2}	Input low voltage	1 0\	′ ≤V _{CC} ≤ 2.7V	-0.6		V _{CC} X0.3	V
V_{IH2}	Input high voltage	1.0 V	ZV _{CC} Z Z./V	V _{CC} X0.7		V _{CC} +1	V
V_{OL1}	Output low voltage		I _{OL} =2.1mA			0.4	V
V _{OH1}	Output high voltage	4.5V ≤V _{CC} ≤ 5.5V	I _{OH} =-0.4mA	2.4			V
V_{OL12}	Output low voltage		I _{OL} =0.15mA			0.2	V
V _{OH2}	Output high voltage	1.8V ≤V _{CC} ≤ 2.7V	I _{OH} =-100uA	V _{CC} -0.2			V



Three-wire Serial EEPROM

Packaging information

DIP-8



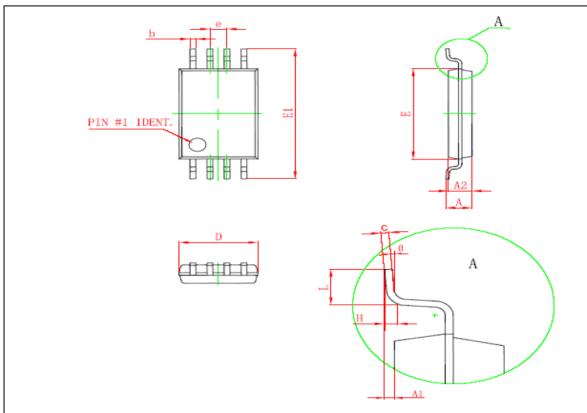
Cymah al	Dimensions Ir	n Millimeters	Dimensions	In Inches
Symbol	Min	Max	Min	Max
Α	3.710	4.310	0.146	0.170
A1	0.510		0.020	
A2	3.200	3.600	0.126	0.142
В	0.380	0.570	0.015	0.022
B1	1.524(1	1.524 (BSC)		BSC)
С	0.204	0.360	0.008	0.014
D	9.000	9.400	0.354	0.370
E	6.200	6.600	0.244	0.260
E1	7.320	7.920	0.288	0.312
е	2.540 (BSC)		0.100 (BSC)
L	3.000	3.600	0.118	0.142
E2	8.400	9.000	0.331	0.354



Three-wire Serial EEPROM

Packaging information

TSSOP-8



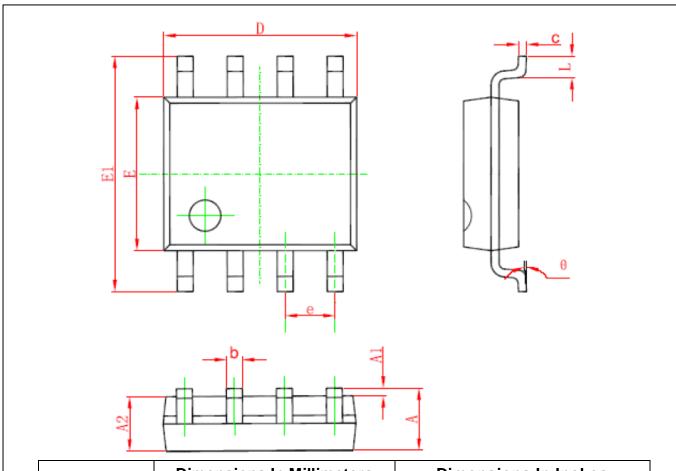
Compleal	Dimensions	In Millimeters	Dimensions	s In Inches
Symbol	Min	Max	Min	Max
D	2.900	3.100	0.114	0.122
Е	4.300	4.500	0.169	0.177
b	0.190	0.300	0.007	0.012
С	0.090	0.200	0.004	0.008
E1	6.250	6.550	0.246	0.258
Α		1.100		0.043
A2	0.800	1.000	0.031	0.039
A1	0.020	0.150	0.001	0.006
е	0.6	0.65 (BSC)		6 (BSC)
L	0.500	0.700	0.020	0.028
Н	0.2	25 (TYP)	0.0	1 (TYP)
θ	1°	7°	1°	7°



Three-wire Serial EEPROM

Packaging information

SOP-8



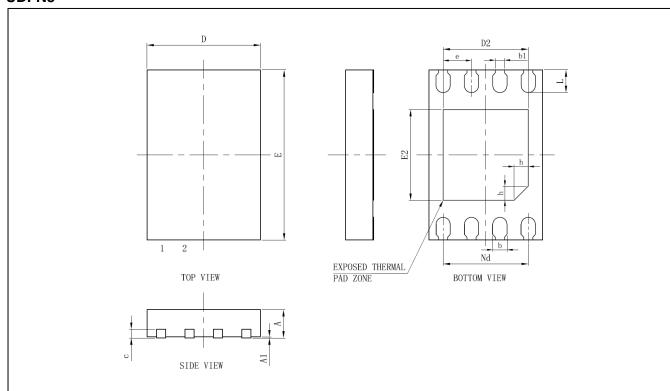
Cumbal	Dimensions I	n Millimeters	Dimensions	In Inches
Symbol	Min	Max	Min	Max
А	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
С	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
Е	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
е	1.270	(BSC)	0.050 (BSC)
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°



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Packaging information

UDFN8



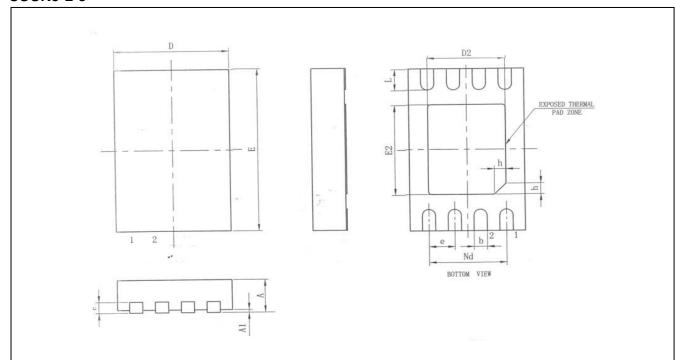
Cumbal	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
Α	0.450	0.550	0.017	0.021
A1	0.000	0.050	0.000	0.002
b	0.180	0.300	0.007	0.039
b1	0.160	REF	0.006	SREF
С	0.100	0.200	0.004	0.008
D	1.900	2.100	0.075	0.083
D2	1.400	1.600	0.055	0.062
е	0.500	0.500BSC		BSC
Nd	1.500	BSC	0.059	BSC
Е	2.900	3.100	0.114	0.122
E2	1.500	1.700	0.059	0.067
L	0.300	0.500	0.012	0.020
h	0.200	0.300	0.066	0.12



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Packaging information

USON3*2-8



Cymbal	Dim	ensions In Millime	eters		
Symbol	Min	Nom	Max		
А	0.70	0.75	0.80		
A1		0.02	0.05		
b	0.18	0.25	0.03		
С	0.18	0.20	0.25		
D	1.90	2.00	2.10		
D2	1.50REF				
е		0.50BSC			
Nd		1.50BSC			
Е	2.90	3.00	3.10		
E2	1.60REF				
L	0.30	0.40	0.50		
h	0.20	0.25	0.30		



ACE93C46A/56A/66A Three-wire Serial EEPROM

Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Technology Co., LTD. As sued herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and shoes failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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